Mean dE/dx with electron_phi40_diag_zm40

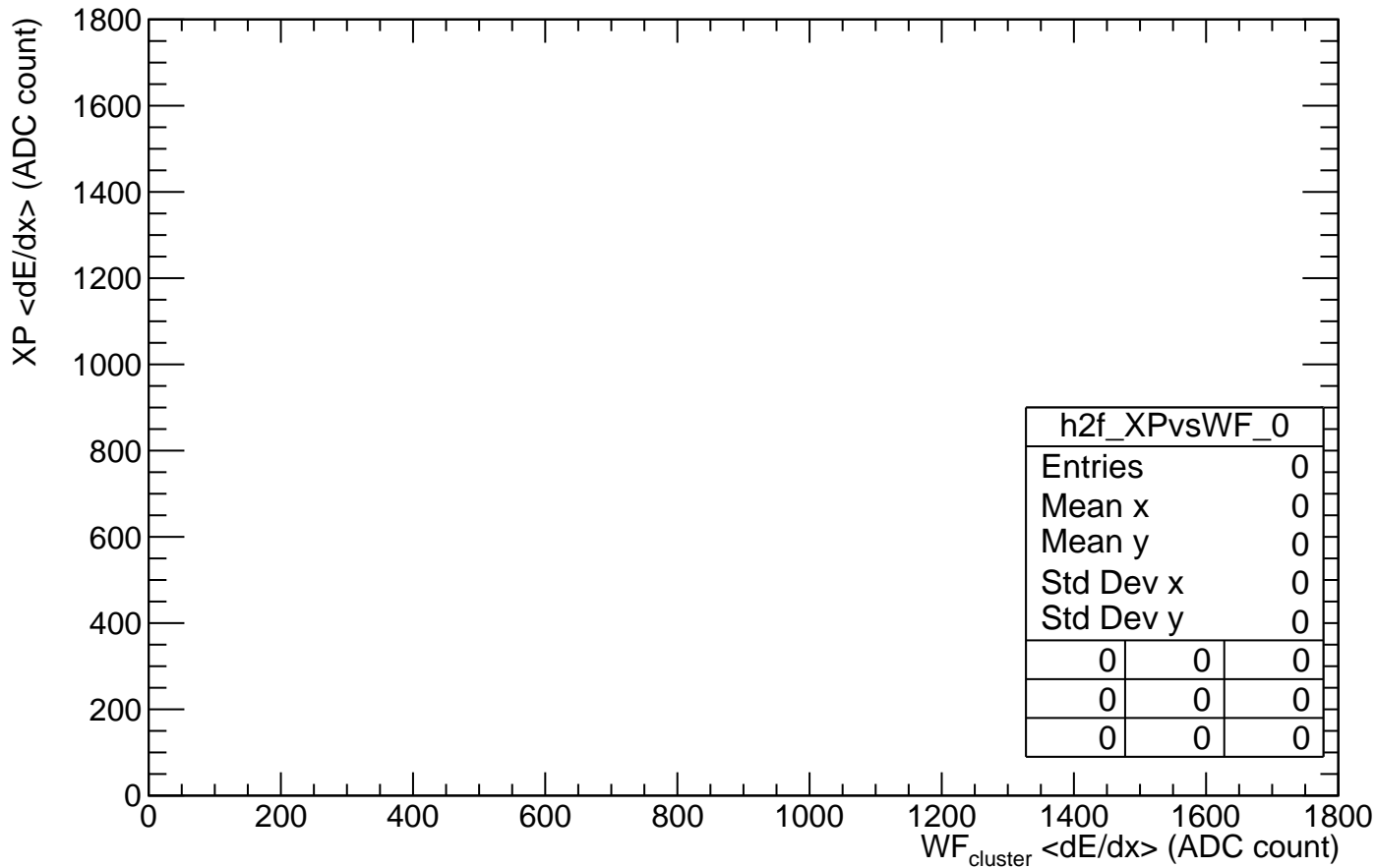$\frac{\sigma}{\mu}(XP) = 7.81 \pm 0.11$ %

$\frac{\sigma}{\mu}(WF_{clus}) = 8.49 \pm 0.13$ %
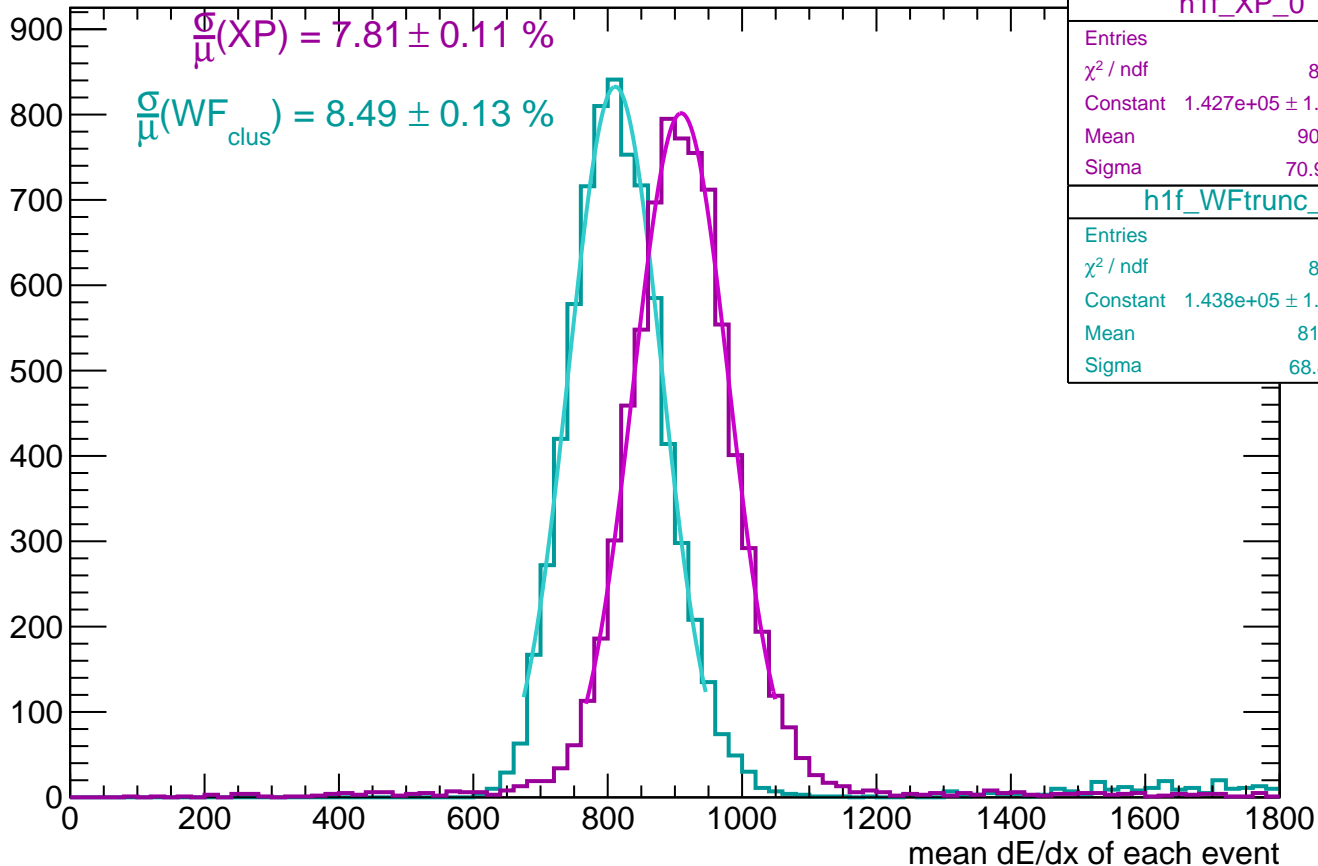
h1f_XP_0	
Entries	7462
χ^2 / ndf	8.013 / 12
Constant	1.427e+05 ± 1.750e+03
Mean	909.4 ± 0.9
Sigma	70.99 ± 0.88

h1f_WFtrunc_0	
Entries	7462
χ^2 / ndf	8.622 / 10
Constant	1.438e+05 ± 1.835e+03
Mean	811.2 ± 1.0
Sigma	68.89 ± 1.01

mean dE/dx of each event

Counts

XP vs WF$_{cluster}$ <dE/dx> (selected data, module 0)

h2f_XPvsWF_0		
Entries		0
Mean x		0
Mean y		0
Std Dev x		0
Std Dev y		0
0	0	0
0	0	0
0	0	0

WF$_{cluster}$ <dE/dx> (ADC count)

XP <dE/dx> (ADC count)

WF$_{\text{not trunc}}$ - WF$_{\text{trunc}}$ vs WF$_{\text{not trunc}}$ (module 0)

h2f_WFmWFvsWF_0		
Entries		0
Mean x		0
Mean y		0
Std Dev x		0
Std Dev y		0
0	0	0
0	0	0
0	0	0

y-axis: WF$_{\text{not trunc}}$ - WF$_{\text{trunc}}$ <dE/dx> (ADC count)

x-axis: WF$_{\text{not trunc}}$ <dE/dx> (ADC count)